Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	ier
10/773,606	KIM, KI IL	
Examiner	Art Unit	
Tuan A. Tran	2618	

SEARCHED					
Class	Subclass	Date	Examiner		
455	3.01-06	3/28/2007	тт		
455	550.1				
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SEARCH NOT (INCLUDING SEARCH		)
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EAST (USPAT, USPGPUB, USOCR, FPRS, JPO, EPO, DERWENT)	3/28/2007	тт
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